Se	arcn Notes	•

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/758,831	CHEN ET AL.	
Examiner	Art Unit	
ALAN S. CHEN	2182	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
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see search history printouts		12/16/2008	ASC

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
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